

Notice of References Cited		Application/Control No. 10/581,576	Applicant(s)/Patent Under Reexamination JIN MI RAM	
		Examiner TIMOTHY E. BETTON	Art Unit 1617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0003432 A1	01-2004	Obukowicz, Mark G.	800/284
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP03120217	05-1991	JAPAN	Akira et al.	A61K 31/34
	O	JP03074378	03-1991	JAPAN	Akira et al.	549/469
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages
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	X	

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